## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10528928	MERCKEN ET AL.
Examiner	Art Unit
Wang, Chang-Yu	1649

SEARCHED			
Subclass	Date	Examiner	

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST, STN: search strategy attached (updated)	5/19/09	CYW	
Inventor name search: EAST, STN, PALM (updated)	5/19/09	CYW	
Sequence search: oligomer search on SEQ ID NOs: 1-4. See search results in SCORE.	5/19/09	CYW	
PLUS search from STIC. See search results in eDAN (4/24/09).	5/19/09	CYW	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

/C. Y. W./ Examiner.Art Unit 1649	

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